## Application/Control No. Applicant(s)/Patent Under Reexamination 10/531,930 DE WIT ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Tuan H. Nguyen 2618 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY US-4,974,251 11-1990 Ohta et al. 455/462 US-В US-С US-D US-Ε US-F US-G US-Н US-1 US-J US-Κ US-US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Classification Country Name Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S T **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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